Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/849,516	TAKAHASHI ET AL.
Examiner	Art Unit
Brian E. Miller	2627

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SEARCHED				
Class	Subclass	Date	Examiner	
360	322,324.1	2/19/2007	BEM	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
PLUS Search	2/14/2007	BEM
EAST Search (enclosed)	2/19/2007	BEM
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